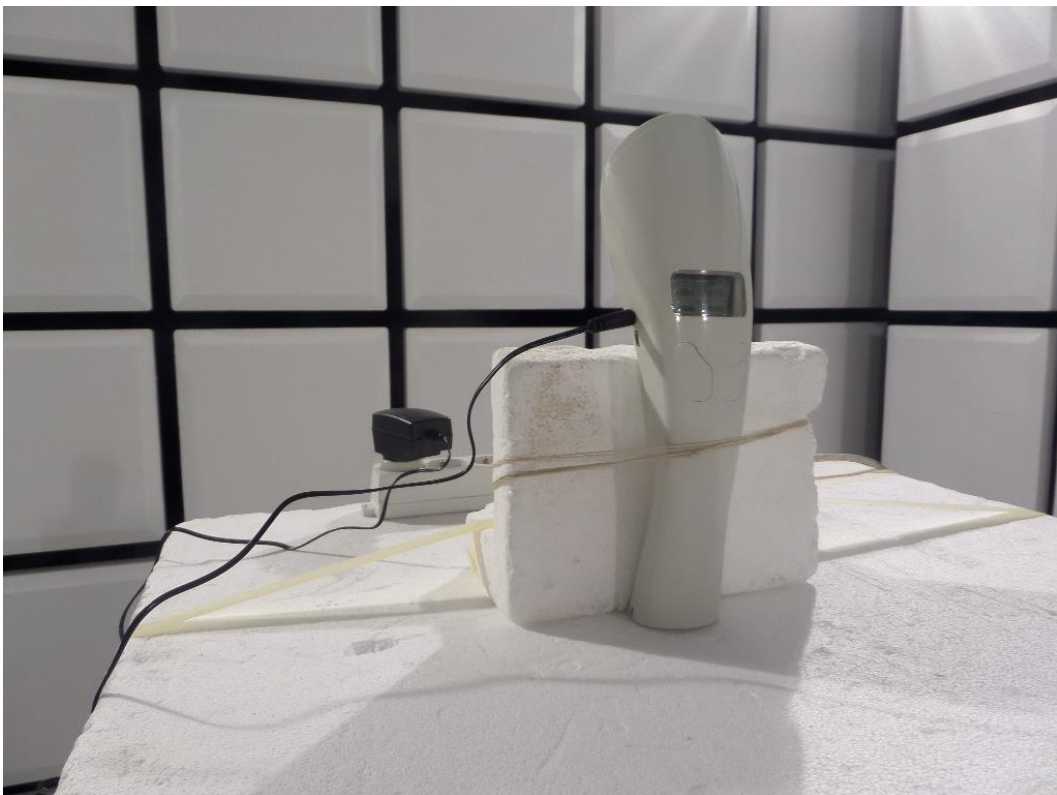
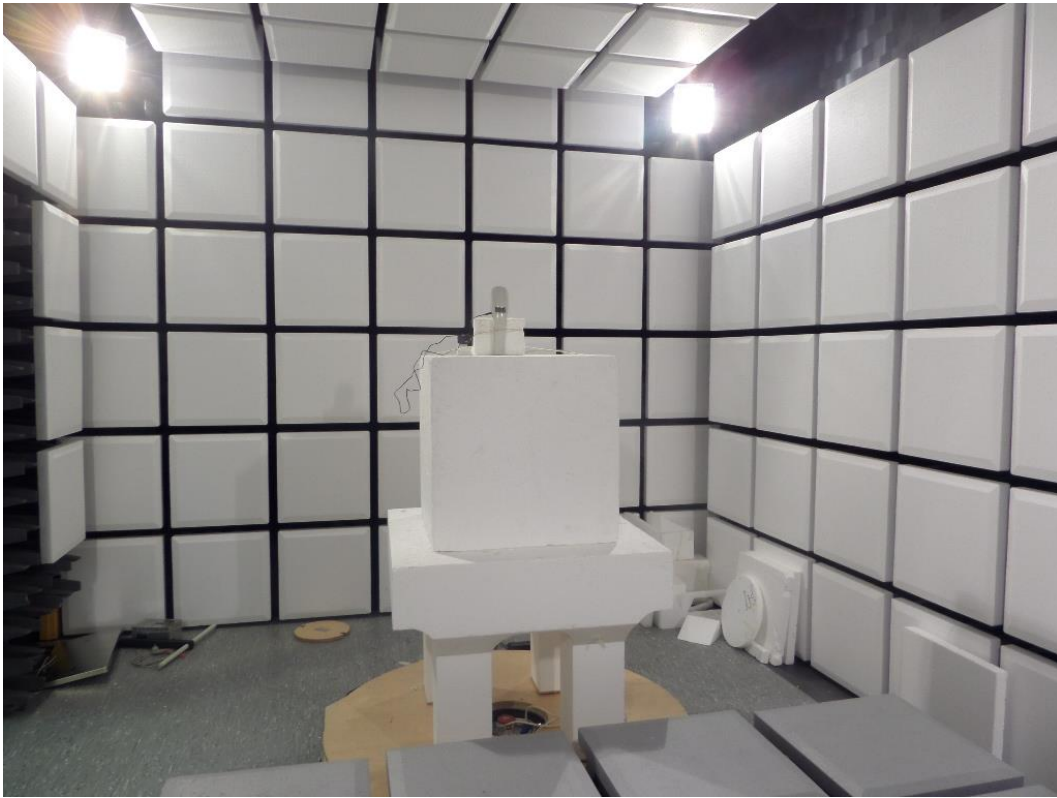
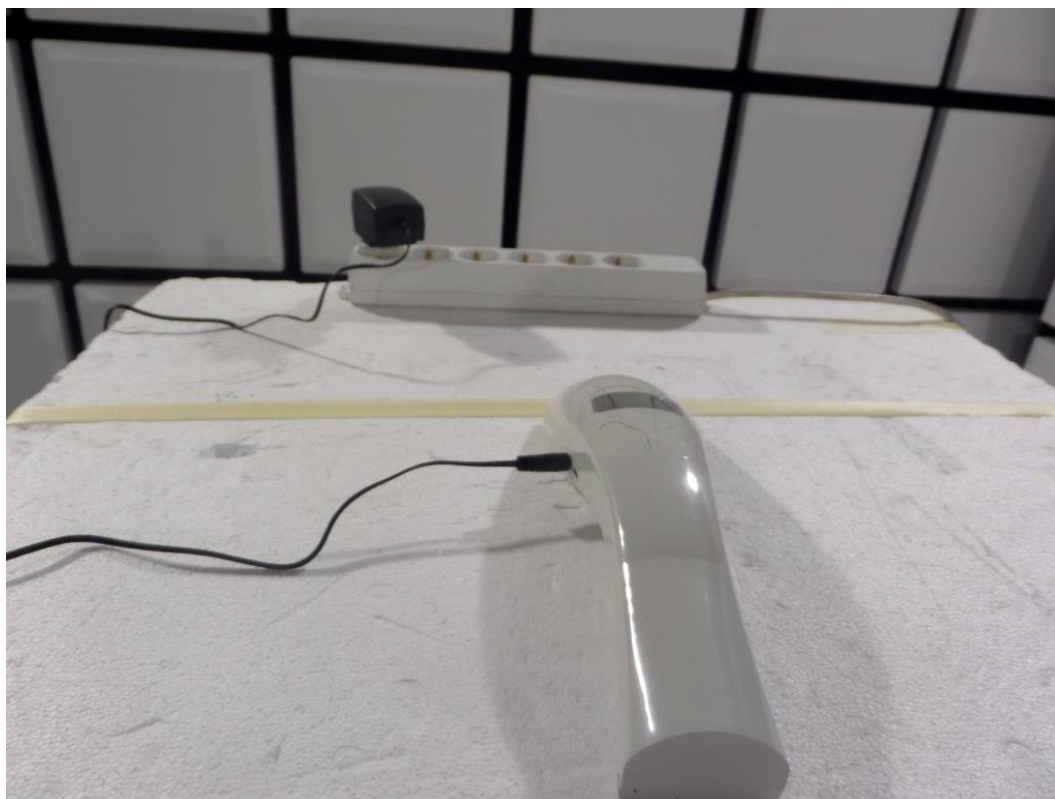


Anechoic chamber setup

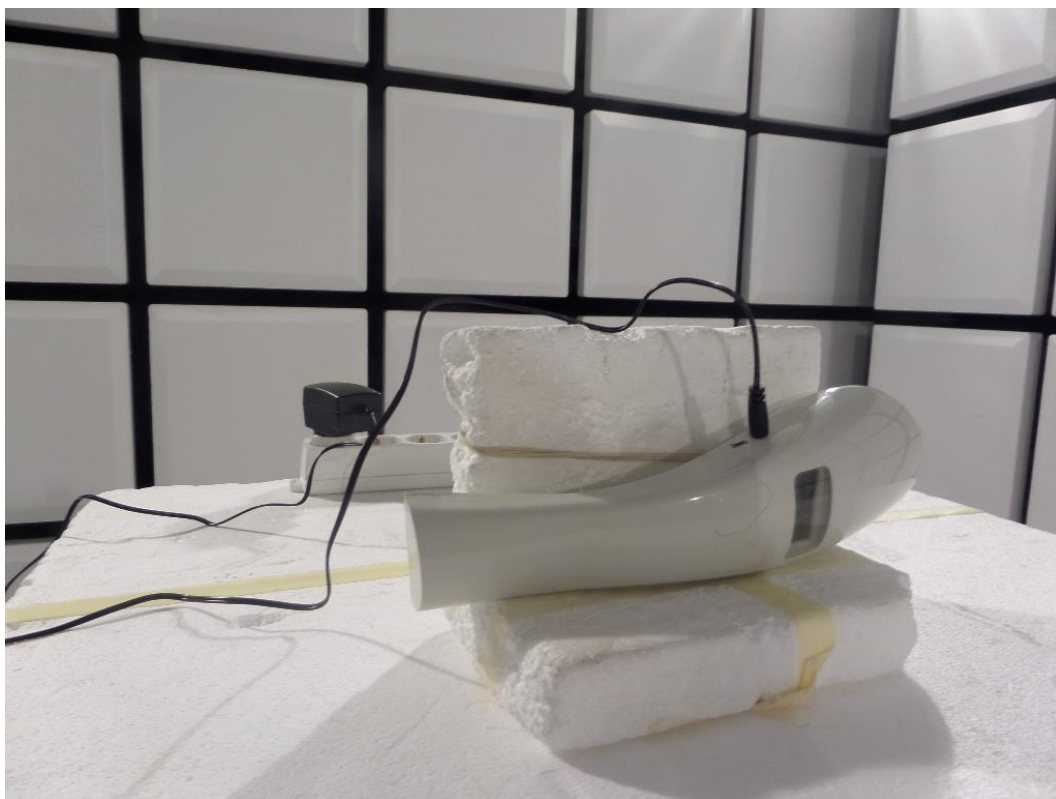
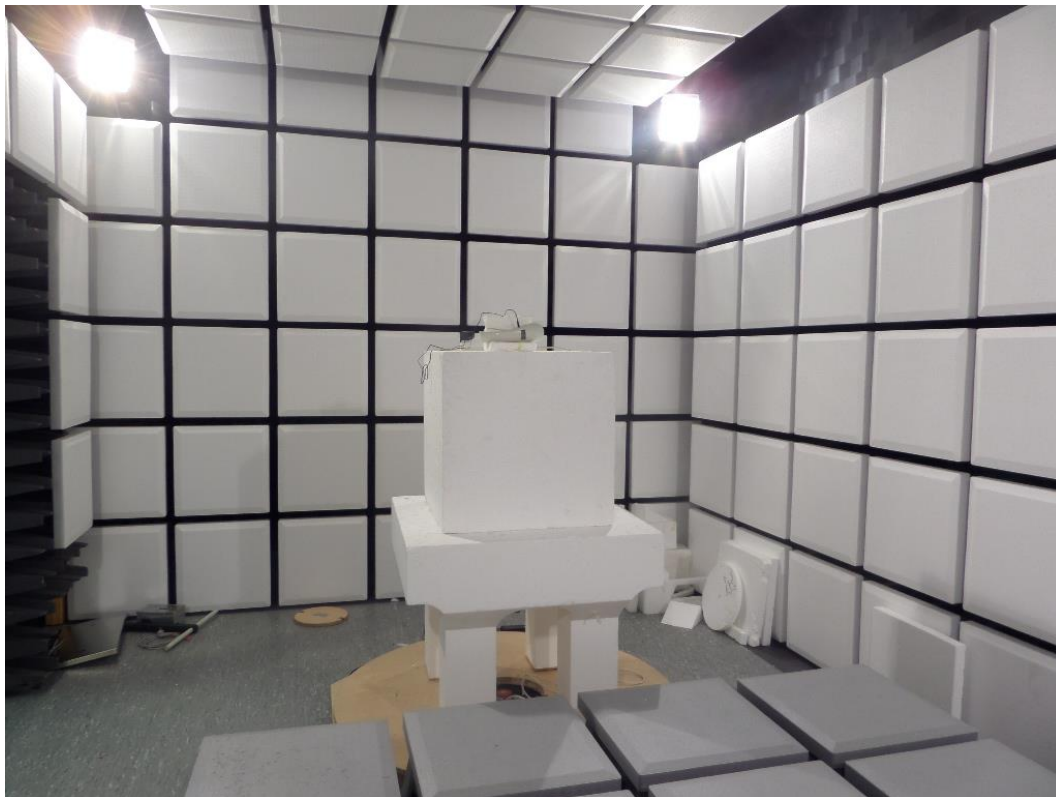
Position 1 in charging mode



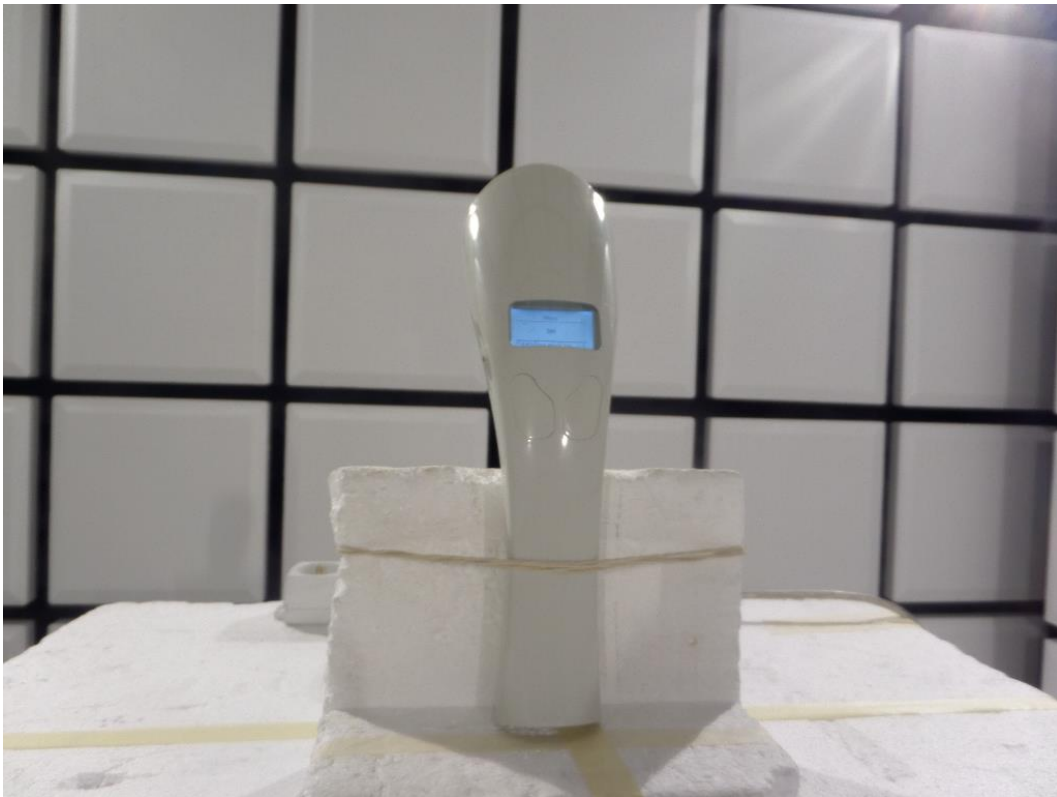
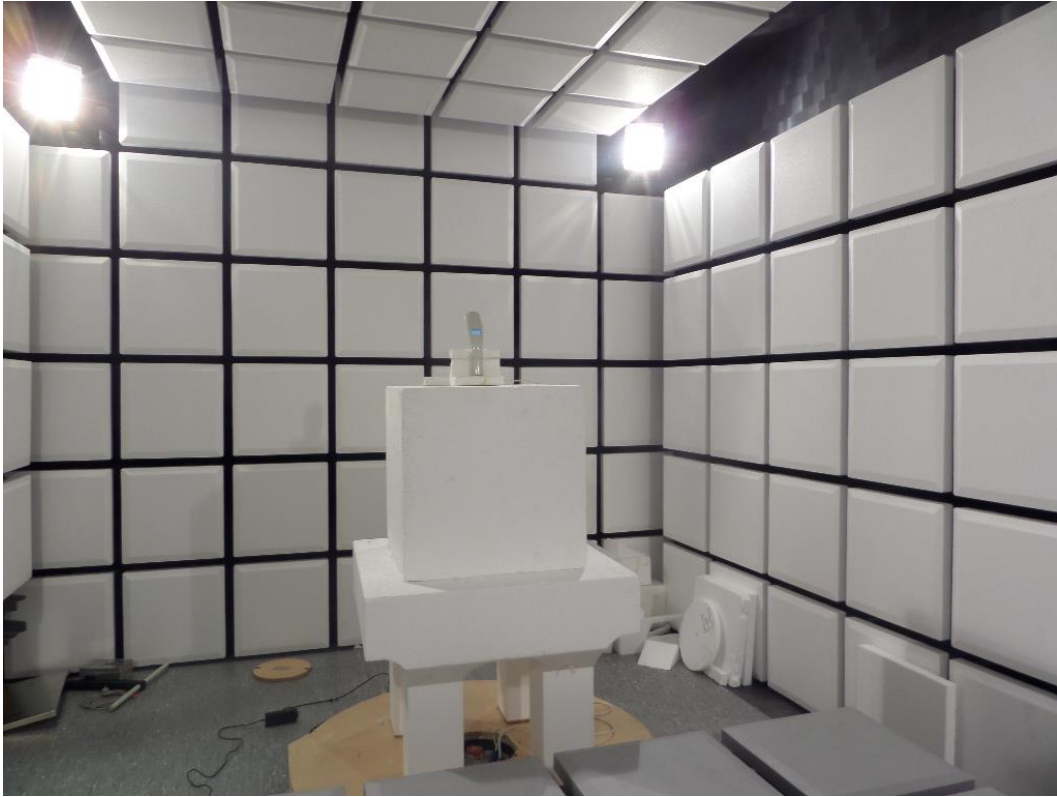
Position 2 in charging mode

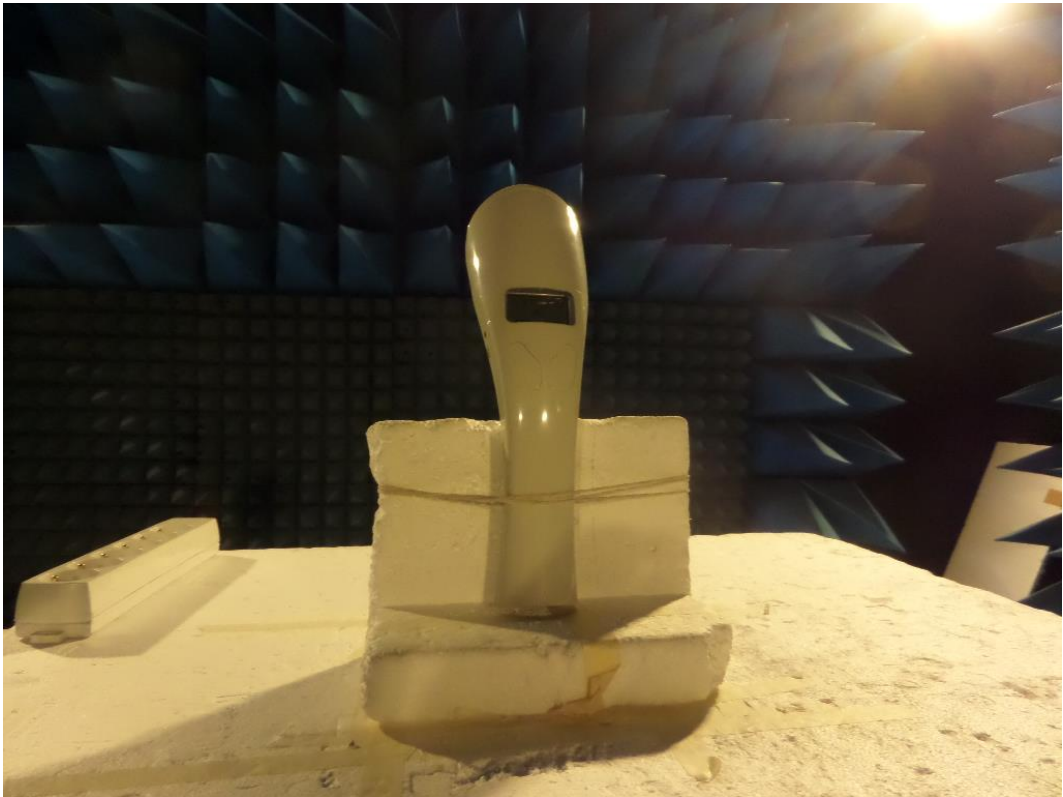
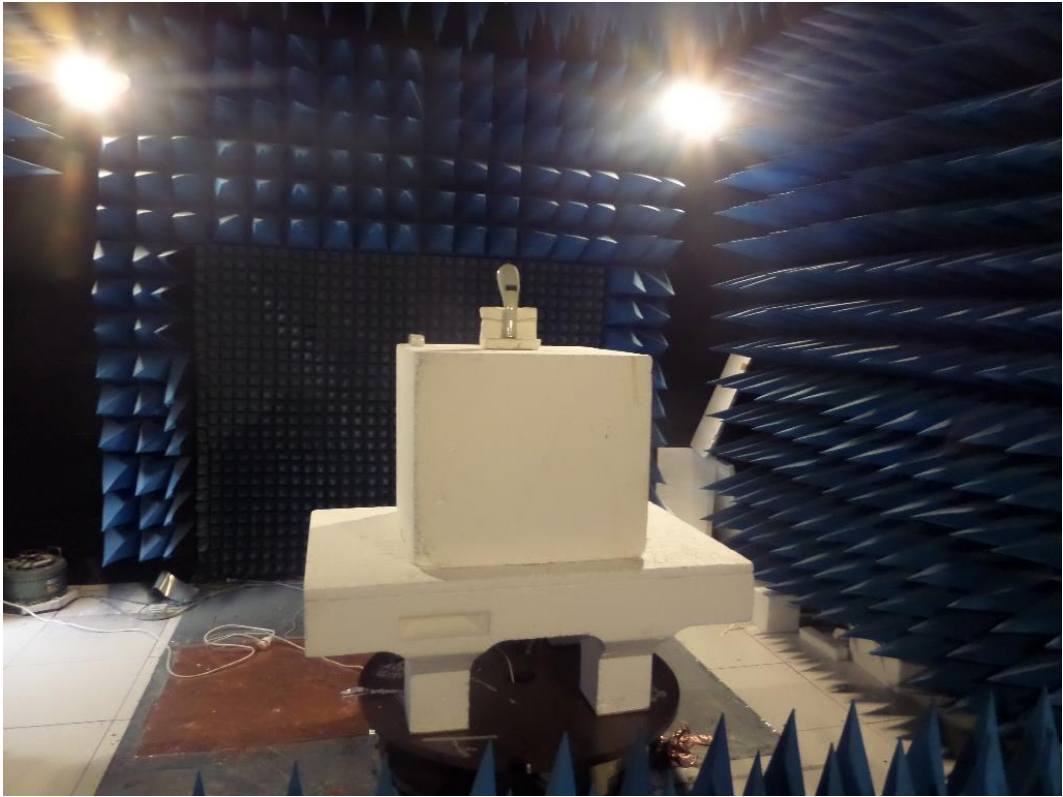


Position 3 in charging mode

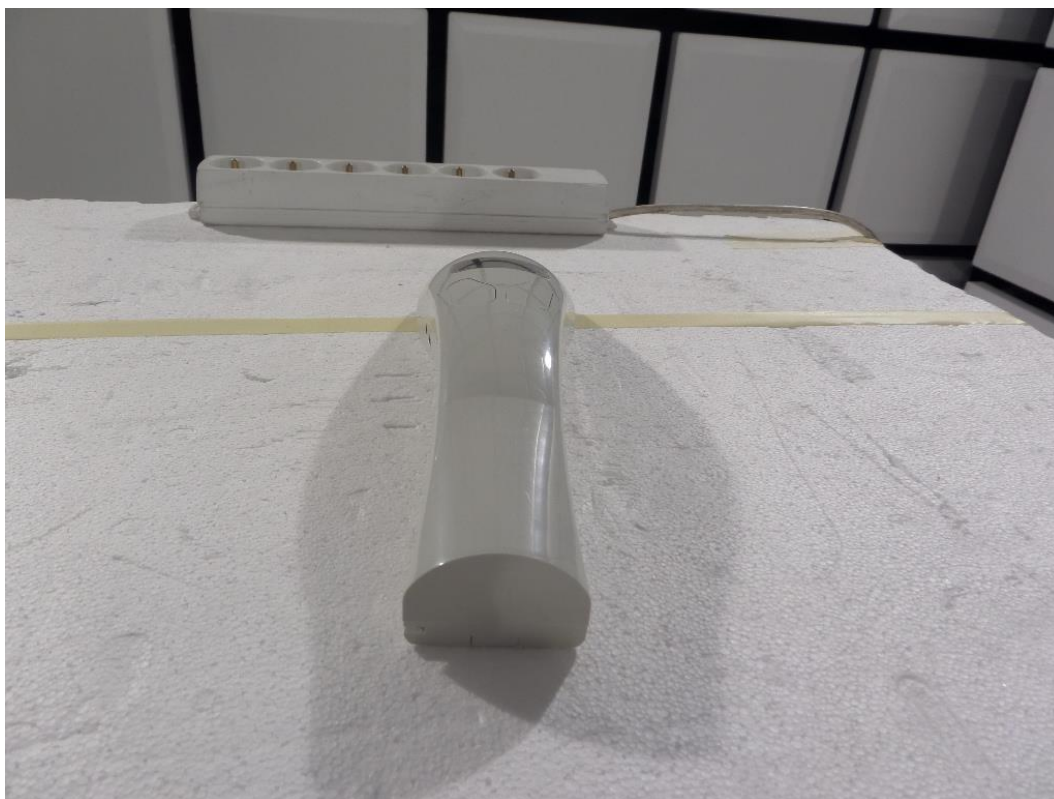


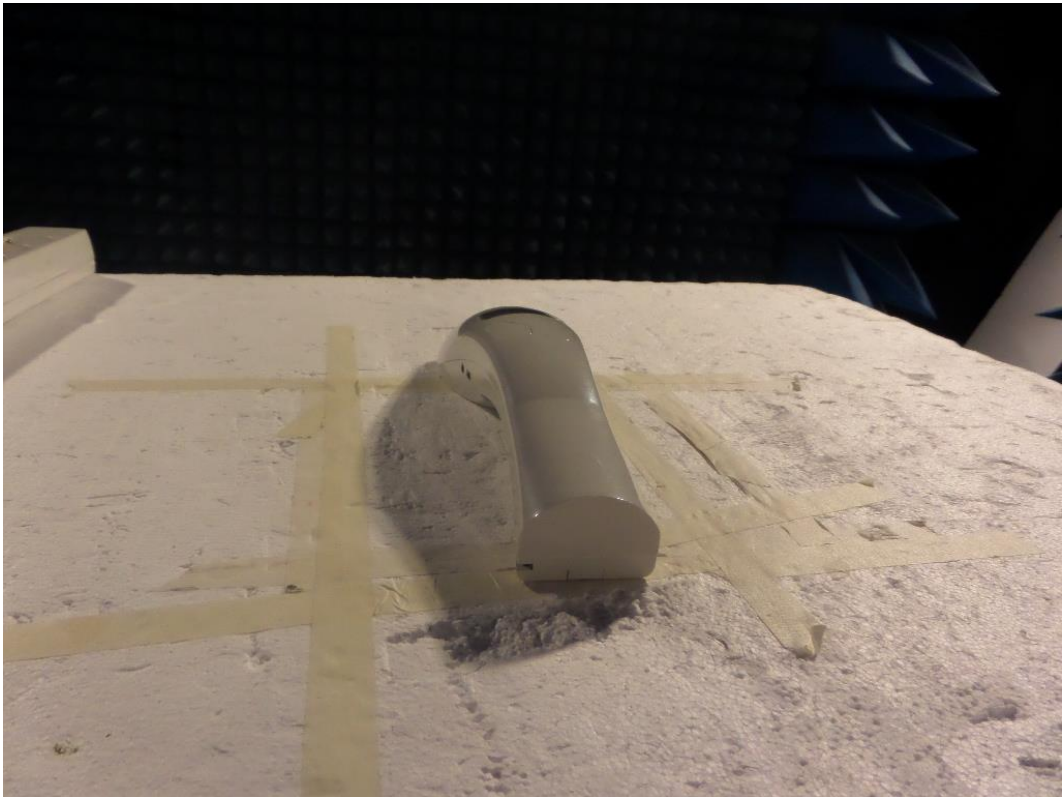
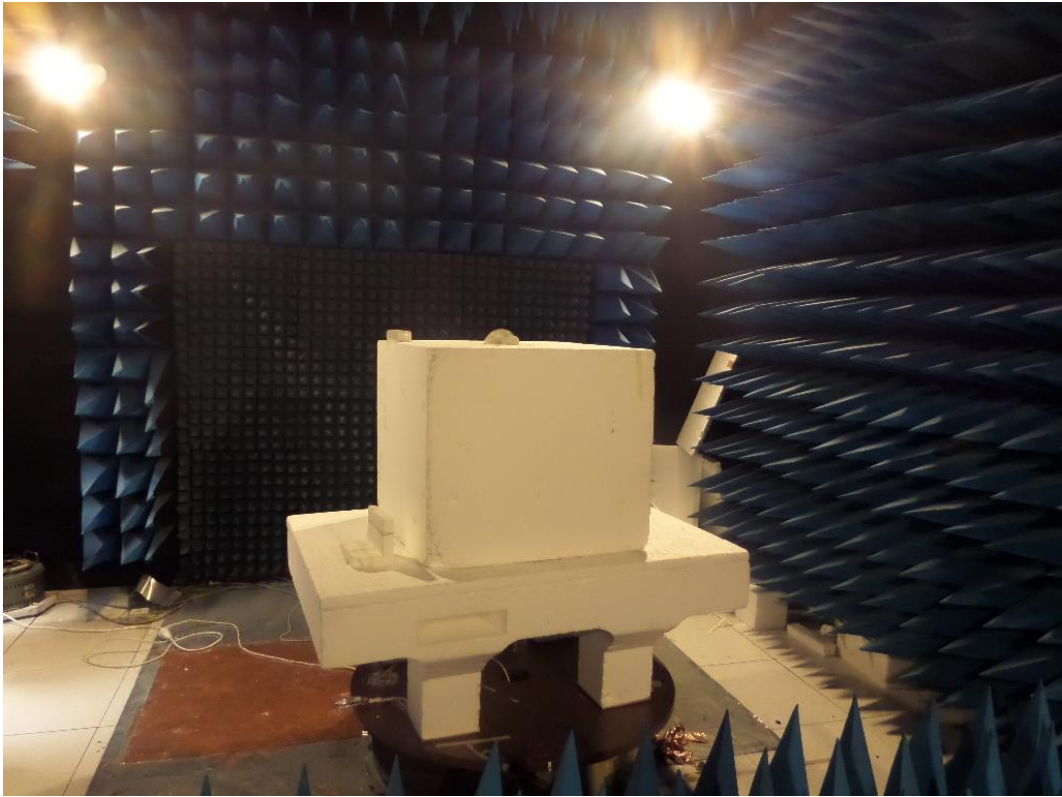
Position 1



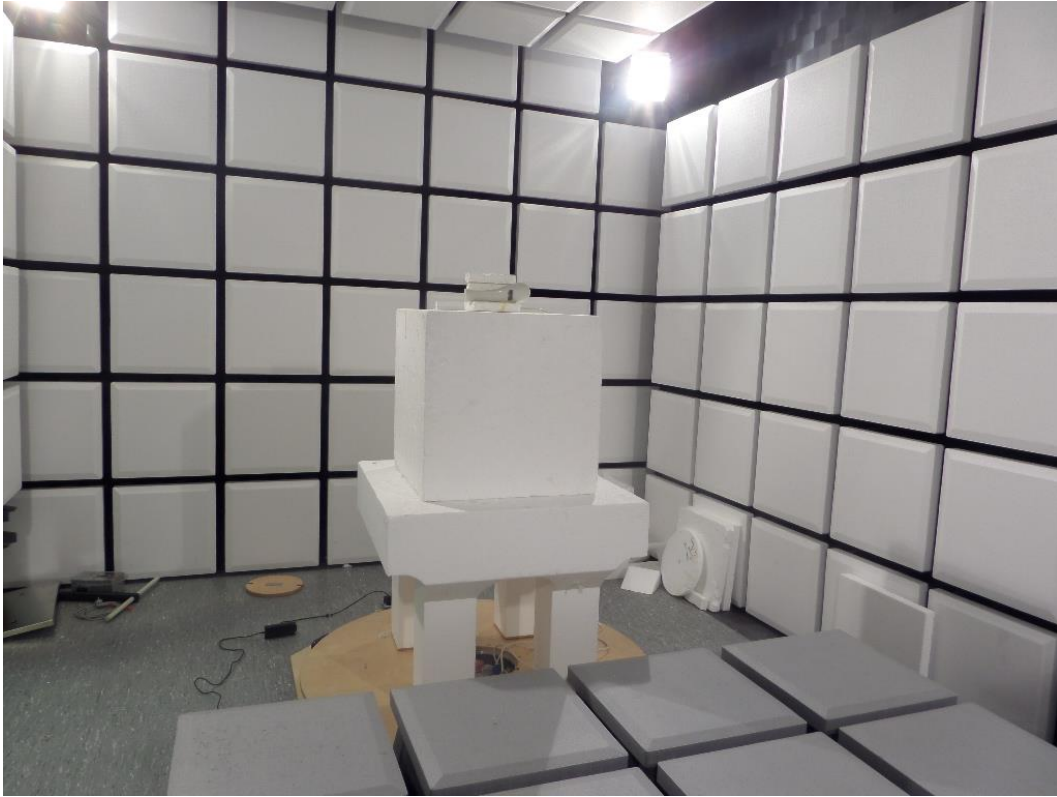


Position 2

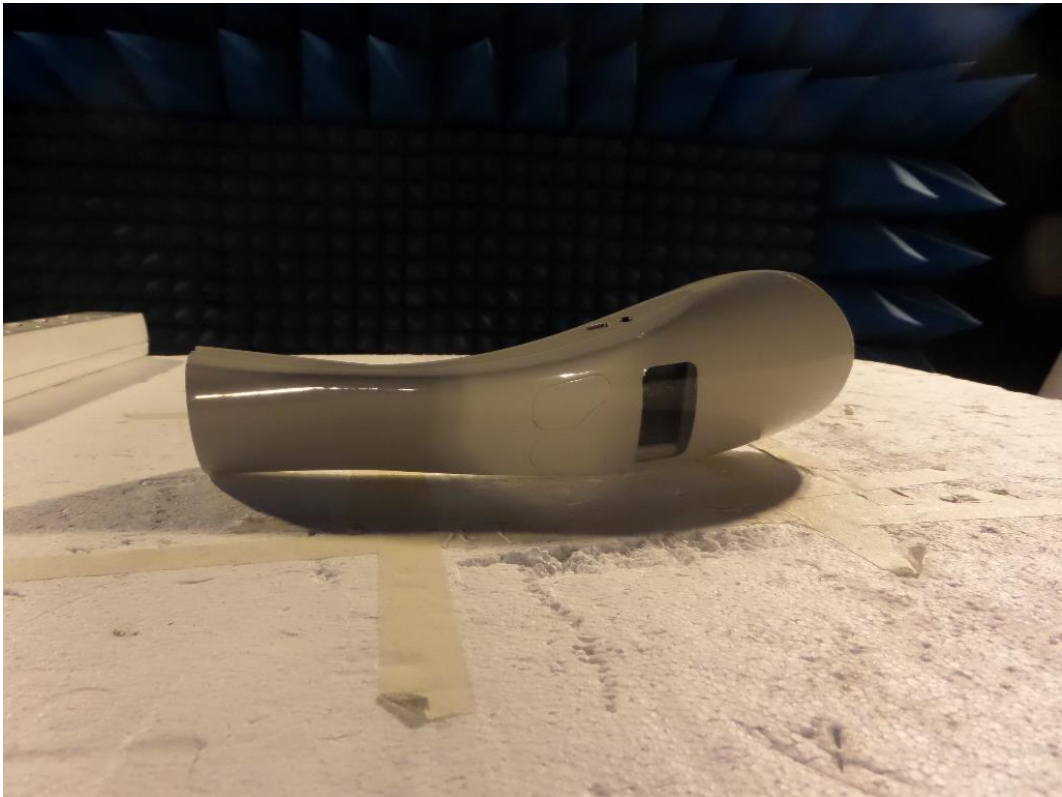
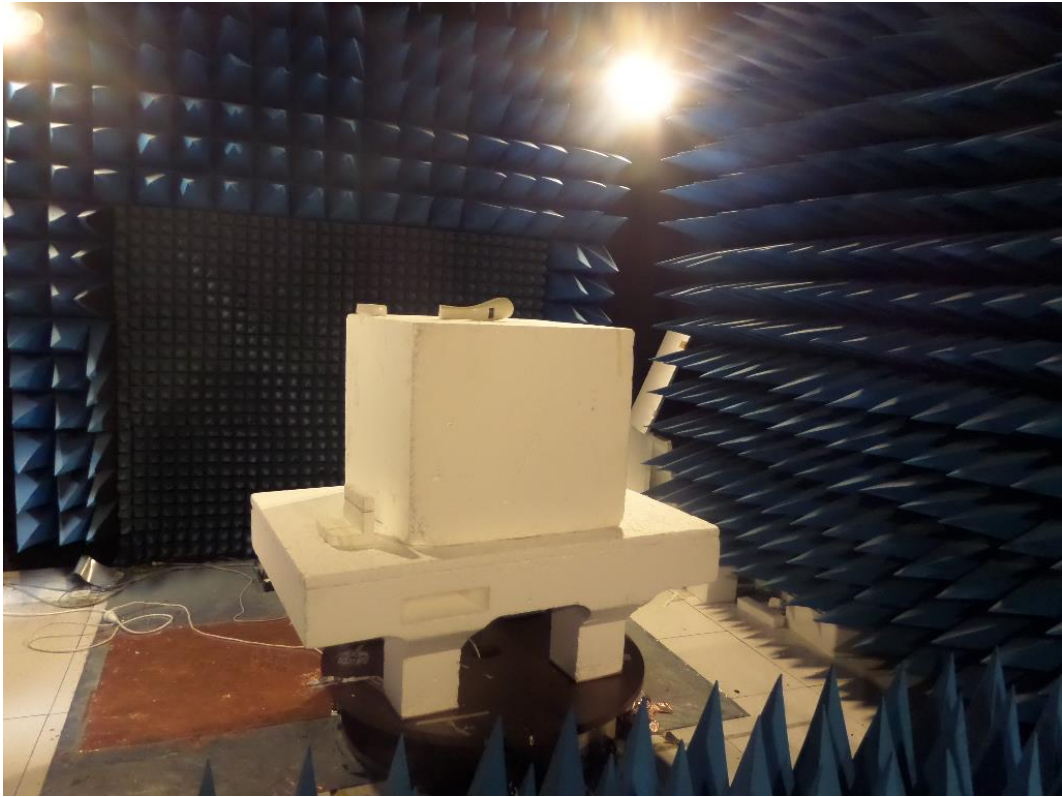




Position 3





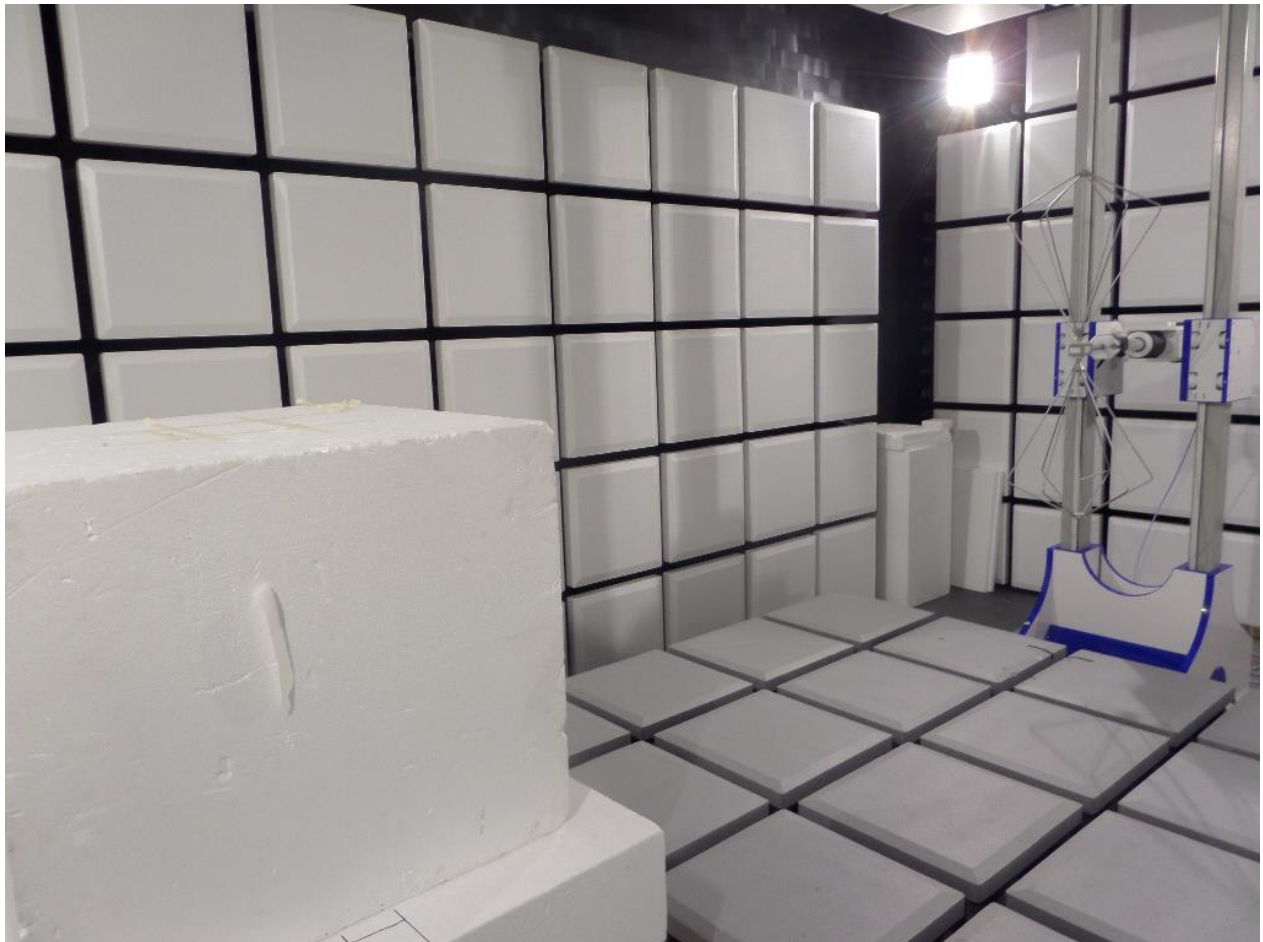


Anechoic chamber test site

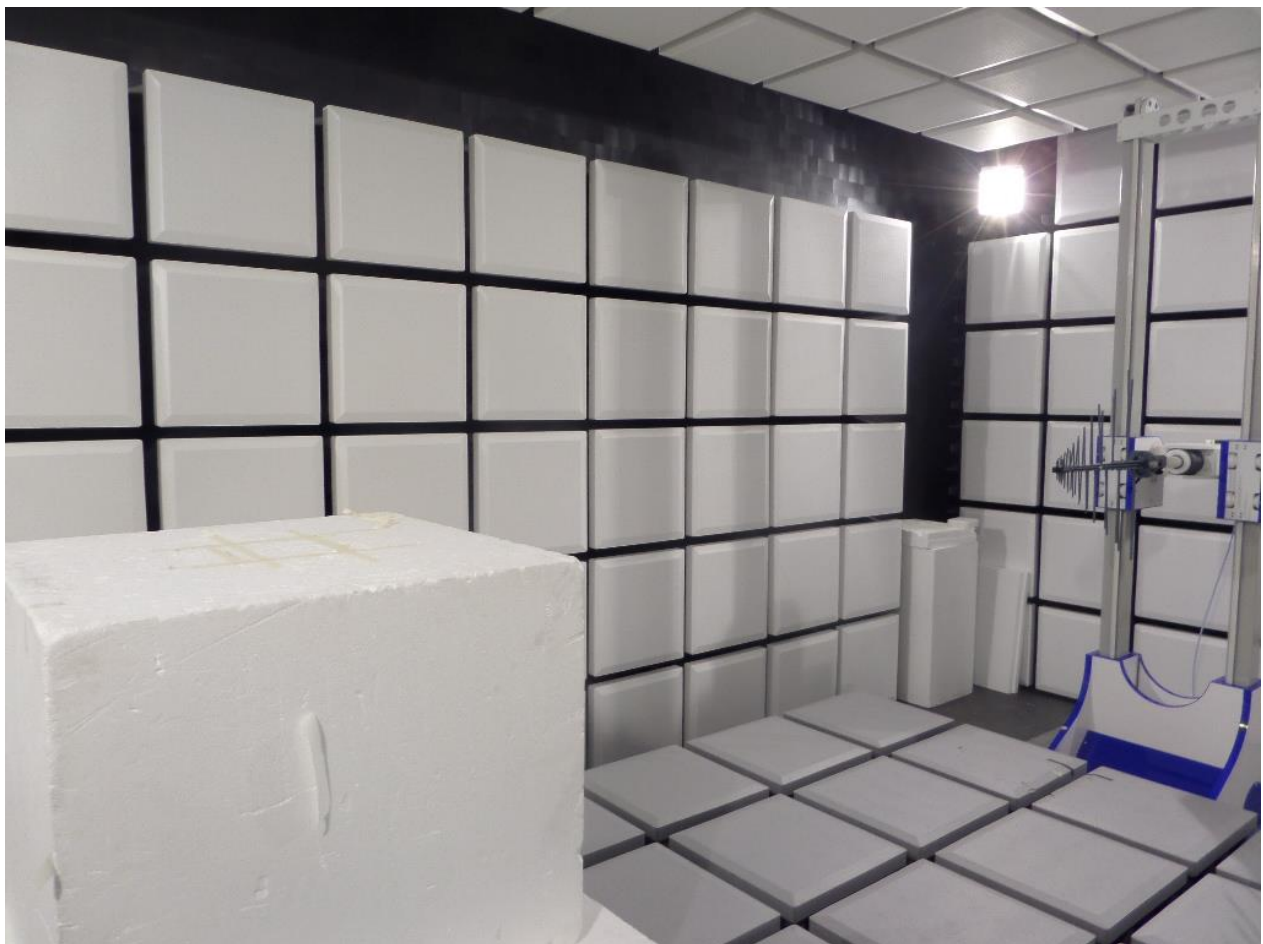
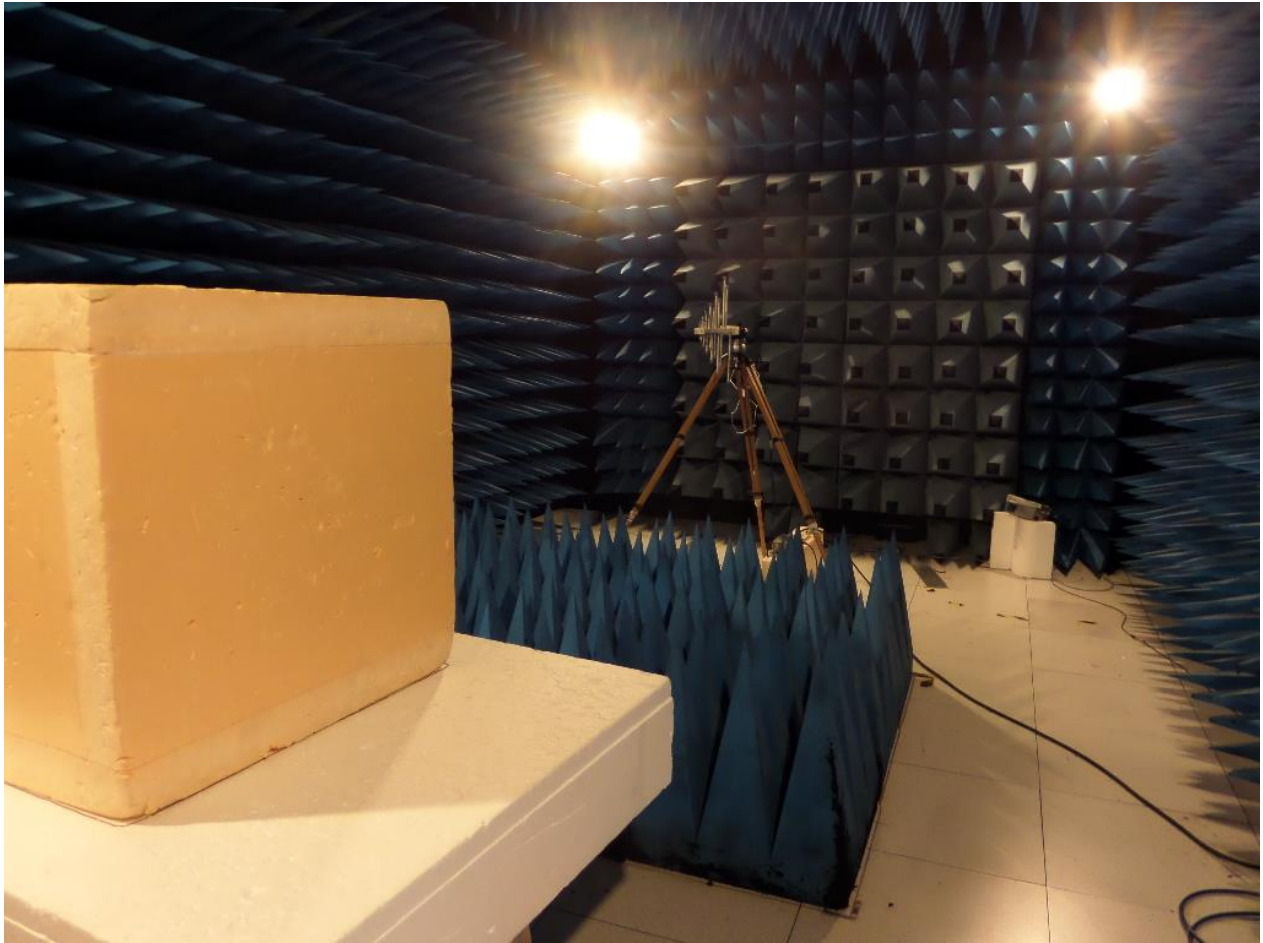
Pre-measure below 30 MHz



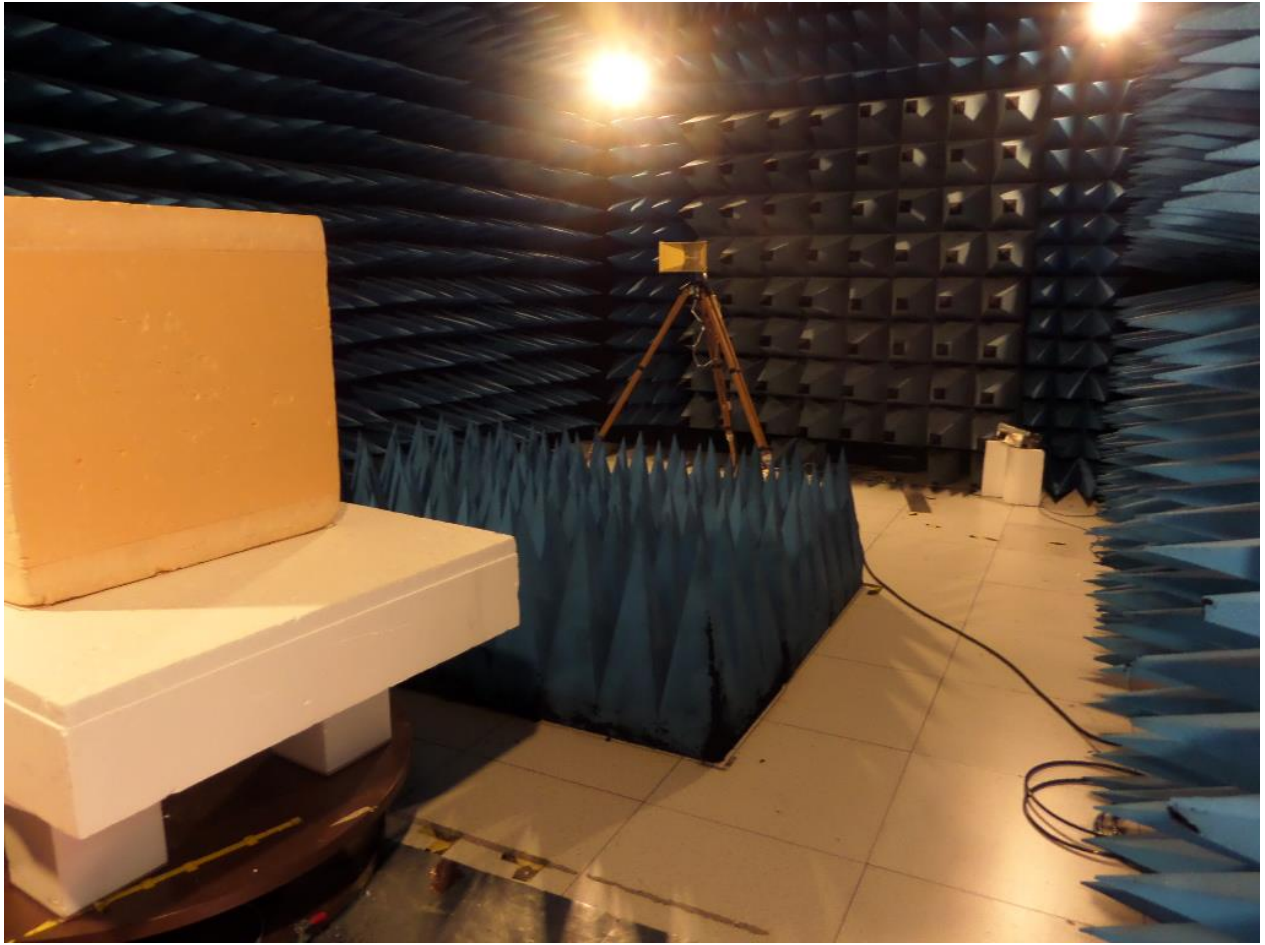
Pre-measure between 30 MHz to 200 MHz



Pre-measure between 200 MHz to 1000 MHz



Measure between 1 GHz to 18 GHz



Measure between 18 GHz to 26 GHz



Open area setup

Position 1

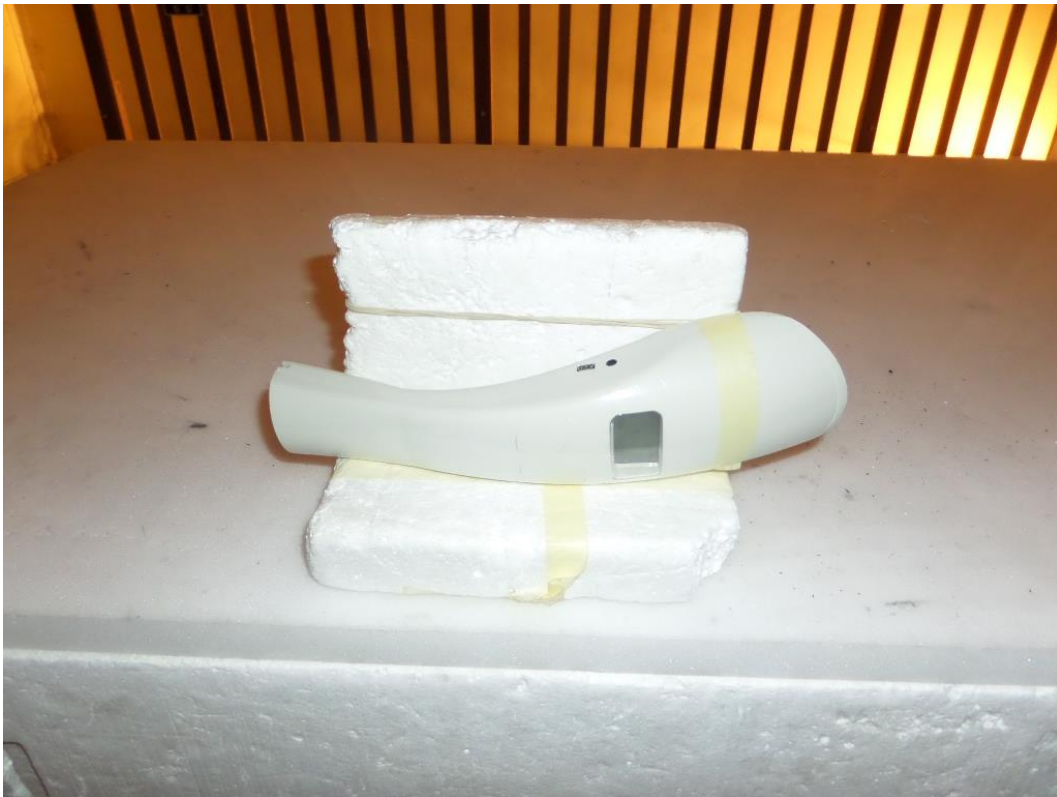


Position 2





Position 3

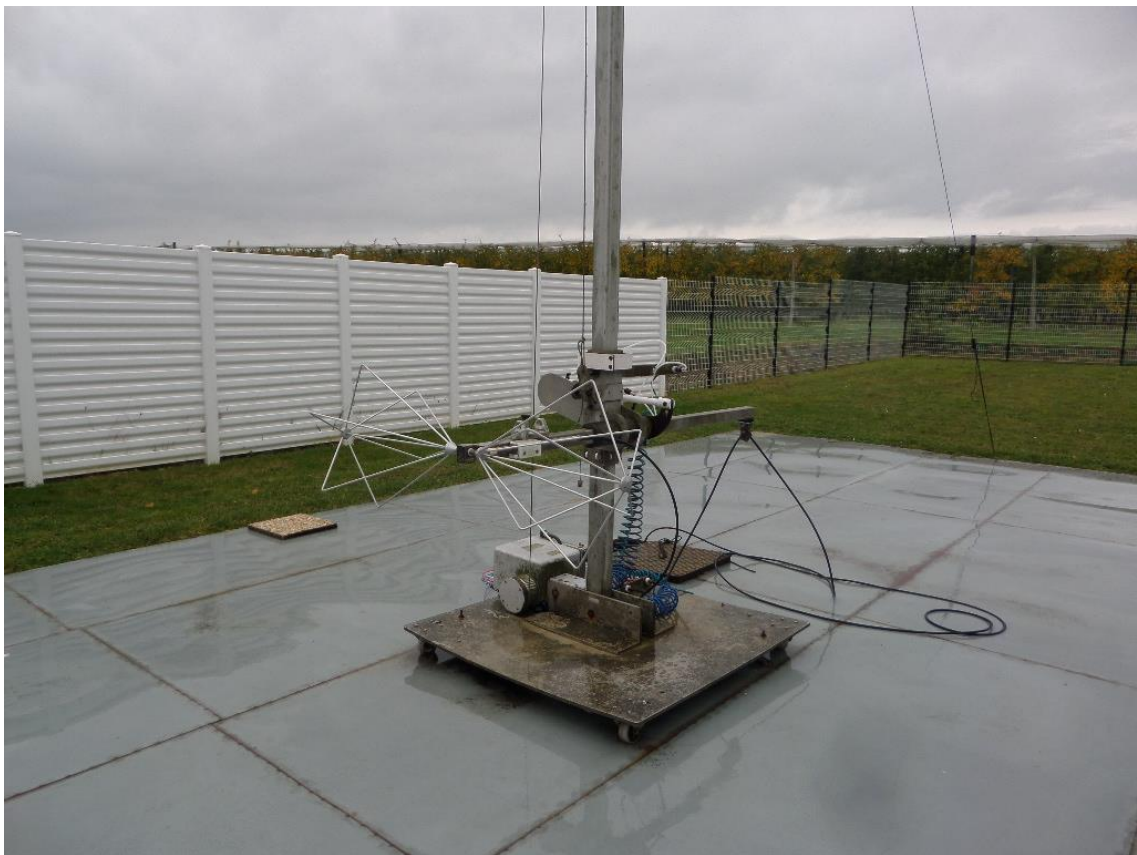


Open area test site

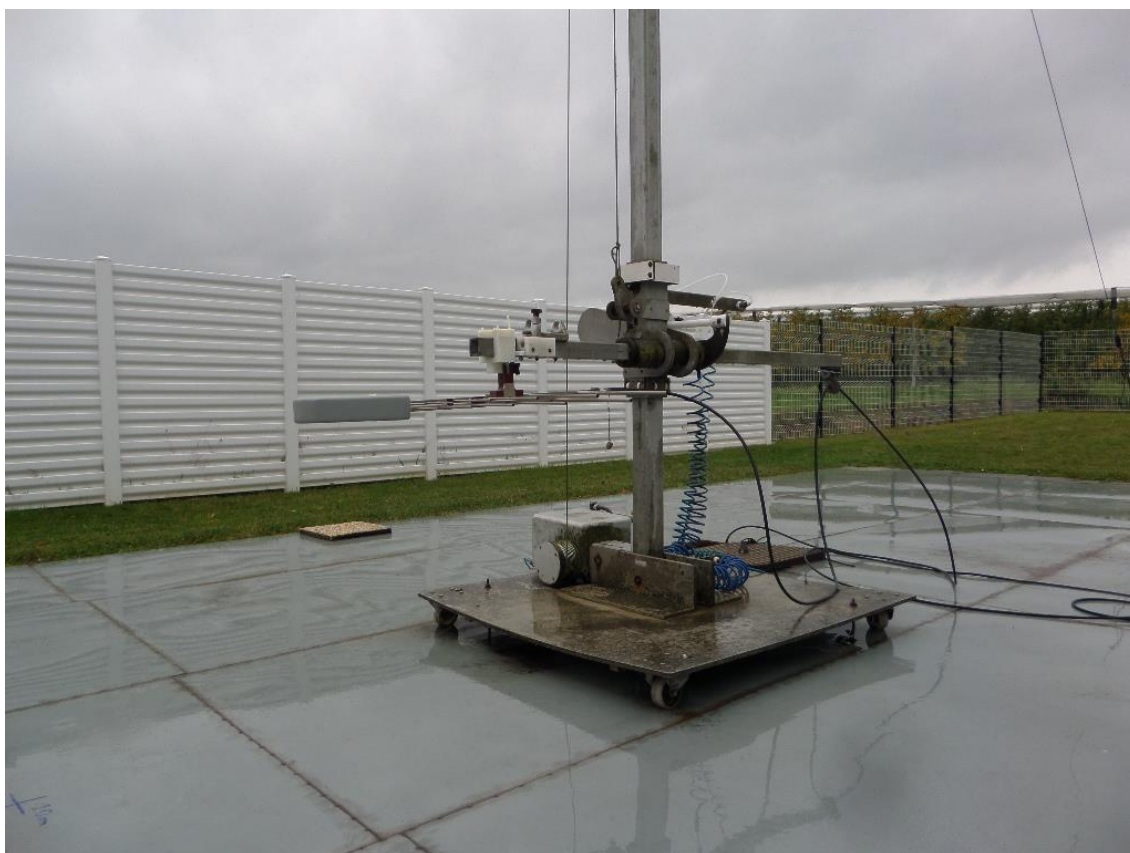
Measure below 30 MHz



Measure between 30 MHz to 200 MHz



Measure between 200 MHz to 1000 MHz



Conducted measurement setup

